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FCB199N65S3 N-Channel SuperFET[®] III MOSFET 650 V, 14 A, 199 m Ω

Features

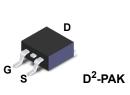
- 700 V @ T_J = 150 ^oC
- Typ. R_{DS(on)} = 170 mΩ
- Ultra Low Gate Charge (Typ. Q_g = 30 nC)
- Low Effective Output Capacitance (Typ. C_{oss(eff.)} = 277 pF)
- 100% Avalanche Tested
- RoHS Compliant

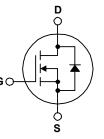
Applications

- Computing / Display Power Supplies
- Telecom / Server Power Supplies
- Industrial Power Supplies

Description

SuperFET[®] III MOSFET is ON Semiconductor's brand-new high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate. Consequently, SuperFET III MOSFET is very suitable for various power system for miniaturization and higher efficiency.





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter Drain to Source Voltage			FCB199N65S3	Unit V	
V _{DSS}				650		
V _{GSS}		- DC		±30	V	
	Gate to Source Voltage	- AC	(f > 1 Hz)	±30	V	
ID	Drain Current	- Continuous (T _C = 25 ^o C)		14	^	
	Drain Current	- Continuous (T _C = 100 ^o C)		9	A	
I _{DM}	Drain Current	- Pulsed	(Note 1)	35	А	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)			76	mJ	
I _{AS}	Avalanche Current (Note 1)			2.5	А	
E _{AR}	Repetitive Avalanche Energy (Note 1)		0.98	mJ		
dv/dt	MOSFET dv/dt			100	V/ns	
	Peak Diode Recovery dv/dt (Note 3)			20		
P _D	Devuer Dissinction	(T _C = 25 ^o C)		98	W	
	Power Dissipation	- Derate Above 25 ^o C		0.79	W/ ^o C	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +150	°C	
TL	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds			300	°C	

Thermal Characteristics

Symbol	Parameter	FCB199N65S3	Unit	
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case, Max.	1.27		
$R_{ hetaJA}$	Thermal Resistance, Junction to Ambient (Minimum Pad of 2-oz Copper), Max.	62.5	°C/W	
	Thermal Resistance, Junction to Ambient (1 in ² Pad of 2-oz Copper), Max.	40		

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Part N	umber	Top Mark	Package	Packing Method	Reel Size	Ð	Tape Width	Qu	antity
FCB199N65S3		FCB199N65S3	D ² -PAK					800 units	
Electrica	l Chara	icteristics T _C = 28	5ºC unless oth	erwise noted.					
Symbol		Parameter		Test Condition	S	Min.	Тур.	Max.	Unit
Off Charac	teristics		<u>.</u>				<u>i</u> i		
	Drain to Source Breakdown Voltage		VG	_S = 0 V, I _D = 1 mA, T _J	= 25°C	650	-	-	V
BV _{DSS}				$V_{GS} = 0 V, I_D = 1 mA, T_J = 150^{\circ}C$		700	-	-	V
∆BV _{DSS} ⊄∆Tj	Breakdown Voltage Temperature Coefficient		I _D =	$I_D = 1 \text{ mA}$, Referenced to 25°C			0.6	-	V/ºC
DSS	Zero Gate Voltage Drain Current			V _{DS} = 650 V, V _{GS} = 0 V		-	-	1	μA
055			VD	V _{DS} = 520 V, T _C = 125 ^o C			0.89	-	μη
I _{GSS}	Gate to Body Leakage Current		V _G	V_{GS} = ±30 V, V_{DS} = 0 V			-	±100	nA
On Charac	teristics								
V _{GS(th)}		eshold Voltage	Ve	_S = V _{DS} , I _D = 1.4 mA		2.5	-	4.5	V
R _{DS(on)}		ain to Source On Resist		$V_{GS} = V_{DS}, I_D = 7.4$ M/A			170	199	mΩ
JFS		Transconductance		$V_{DS} = 20 \text{ V}, \text{ I}_{D} = 7 \text{ A}$			10	-	S
Oynamic C	haracte	ristics							-
C _{iss}	Input Capacitance		VD	V _{DS} = 400 V, V _{GS} = 0 V,		-	1225	-	pF
C _{oss}	Output Capacitance		f =	f = 1 MHz			30	-	pF
C _{oss(eff.)}	Effective Output Capacitance		V _D	V_{DS} = 0 V to 400 V, V_{GS} = 0 V			277	-	pF
C _{oss(er.)}	Energy Related Output Capacitance		nce V _D	V_{DS} = 0 V to 400 V, V_{GS} = 0 V		-	43	-	pF
Q _{g(tot)}		e Charge at 10V	VD	V _{DS} = 400 V, I _D = 7 A, V _{GS} = 10 V		-	30	-	nC
Q _{gs}	Gate to S	ource Gate Charge	V _G			-	7.4	-	nC
Q _{gd}		rain "Miller" Charge			(Note 4)	-	13	-	nC
ESR	Equivaler	nt Series Resistance	f =	1 MHz		-	7	-	Ω
Switching	Characte	eristics							
d(on)	Turn-On [Delay Time		V_{DD} = 400 V, I _D = 7 A, V_{GS} = 10 V, R _g = 4.7 Ω		-	19	-	ns
t _r	Turn-On F	Rise Time				-	23	-	ns
t _{d(off)}	Turn-Off [Delay Time	V _G			-	52	-	ns
t _f	Turn-Off F	all Time			(Note 4)	-	15	-	ns
Source-Dr	ain Diod	e Characteristics							
I _S	Maximum Continuous Source to Drain Diode For			orward Current		-	-	14	Α
I _{SM}	Maximum Pulsed Source to Drain Diode F						-	35	Α
V _{SD}	Source to	Source to Drain Diode Forward Voltage		$V_{GS} = 0 V, I_{SD} = 7 A$			-	1.2	V
t _{rr}	Reverse F	Recovery Time	-	$V_{GS} = 0 V, I_{SD} = 7 A,$ $dI_F/dt = 100 A/\mu s$		-	256	-	ns
Q _{rr}	Reverse F	Recovery Charge				-	3.5	-	μC
. I _{AS} = 2.5 A, R _G . I _{SD} ≤ 7 A, di/dt ≤	= 25 Ω, starting 200 A/μs, V _{DD}	nited by maximum junction tem T _J = 25°C. \leq 400 V, starting T _J = 25°C. rating temperature typical chara							

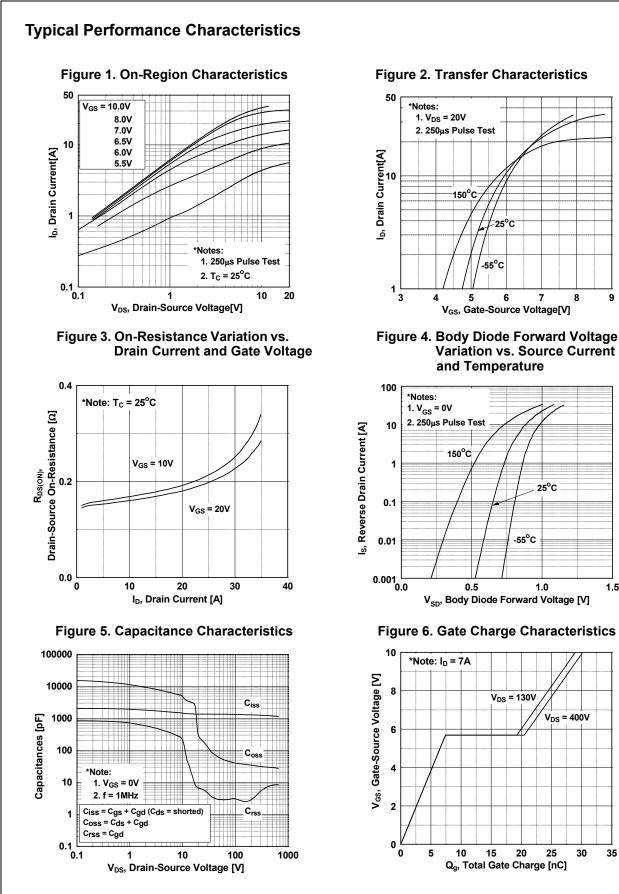


Figure 2. Transfer Characteristics

7

25°C

1.0

V_{DS} = 400V

-55°C

20

25

30

35

8

9

1.5





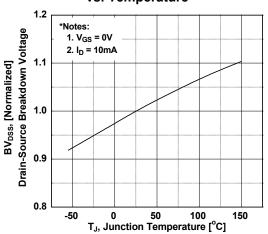


Figure 9. Maximum Safe Operating Area

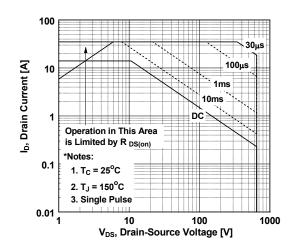
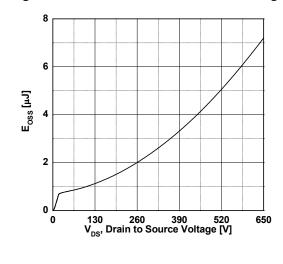


Figure 11. Eoss vs. Drain to Source Voltage



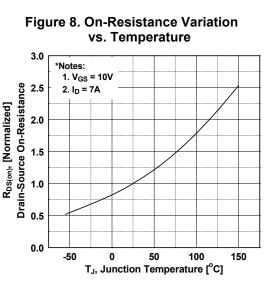
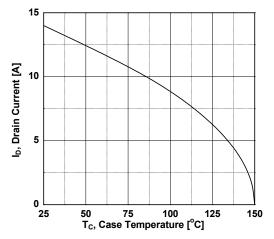
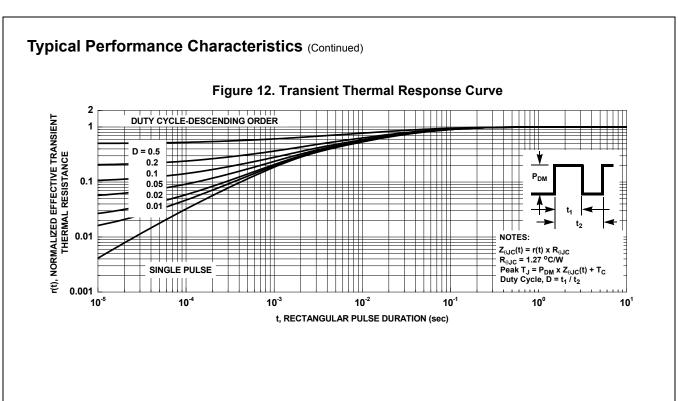
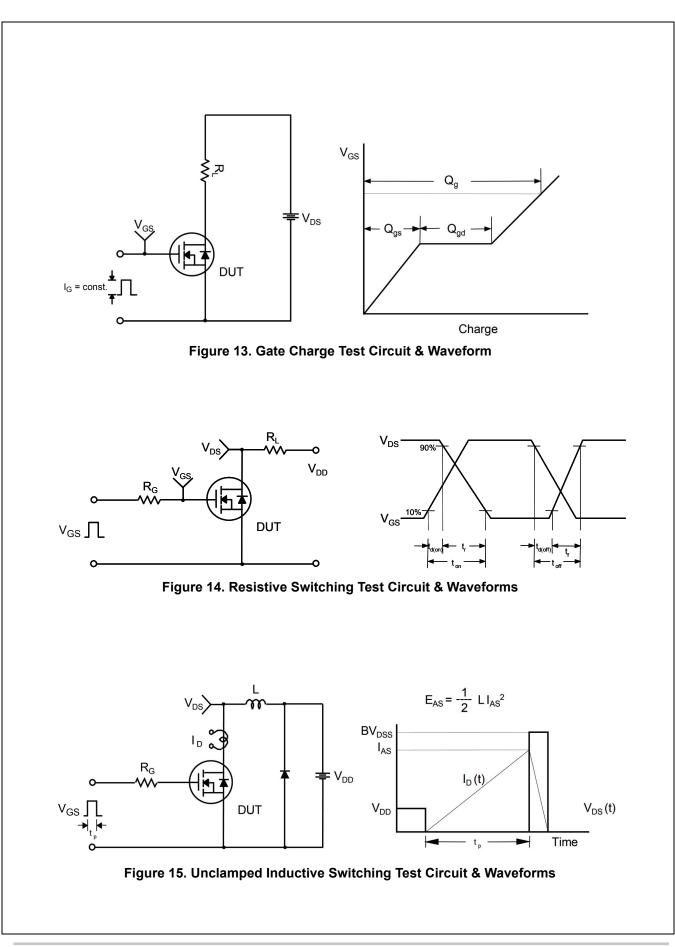


Figure 10. Maximum Drain Current vs. Case Temperature



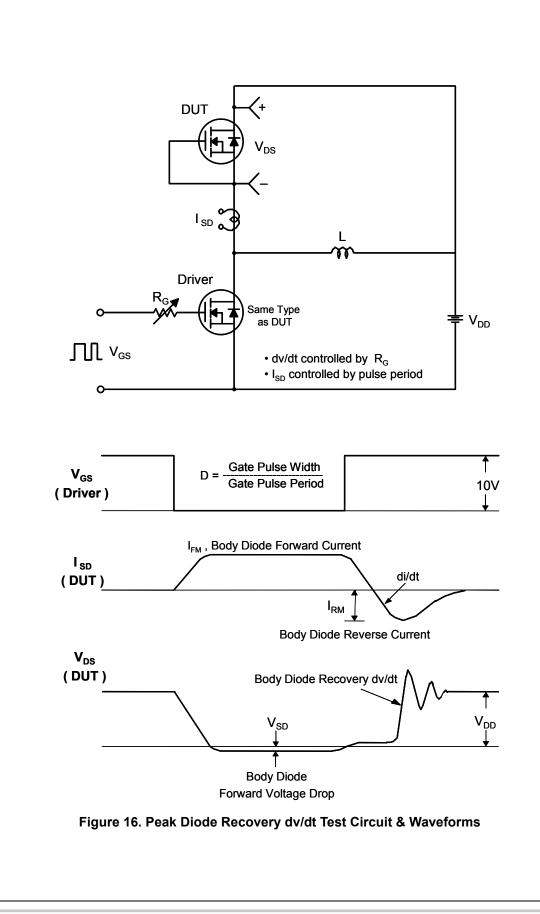


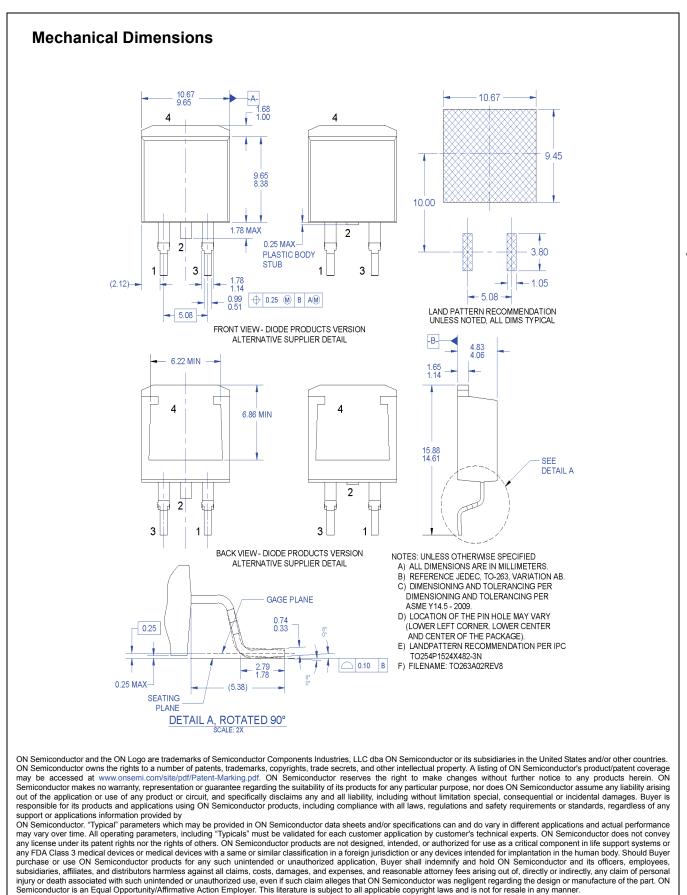




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